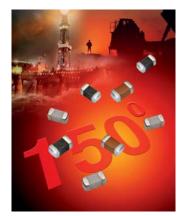
X8R/X8L Dielectric

General Specifications



AVX has developed a range of multilayer ceramic capacitors designed for use in applications up to 150° C. These capacitors are manufactured with an X8R and an X8L dielectric material. X8R material has capacitance variation of $\pm 15^{\circ}$ C between -55°C and +150°C. The X8L material has capacitance variation of $\pm 15^{\circ}$ C between -55°C to 125° C and +15/-40% from +125°C to +150°C.

The need for X8R and X8L performance has been driven by customer requirements for parts that operate at elevated temperatures. They provide a highly reliable capacitor with low loss and stable capacitance over temperature.

They are ideal for automotive under the hood sensors, and various industrial applications. Typical industrial application would be drilling monitoring system. They can also be used as bulk capacitors for high temperature camera modules.

Both X8R and X8L dielectric capacitors are automotive AEC-Q200 qualified. Optional termination systems, tin, FLEXITERM® and conductive epoxy for hybrid applications are available. Providing this series with our FLEXITERM® termination system provides further advantage to customers by way of enhanced resistance to both, temperature cycling and mechanical damage.

PART NUMBER (see page 2 for complete part number explanation)

0805	<u>5</u>	<u>F</u>	104	K	4	_	<u>2</u>	A
Size 0603 0805 1206	Voltage 16V = Y 25V = 3 50V = 5 100V = 1	Dielectric X8R = F X8L = L	Capacitance Code (In pF) 2 Sig. Digits + Number of Zeros e.g. 10µF = 106	Capacitance Tolerance J = ± 5% K = ±10% M = ± 20%	Failure Rate 4 = Automotive A = Not Applicable	Terminations T = Plated Ni and Sn Z = FLEXITERM®	Packaging 2 = 7" Reel 4 = 13" Reel	Special Code A = Std. Product

NOTE: Contact factory for availability of Termination and Tolerance Options for Specific Part Numbers.

X8R (Flexiterm Offered)

SIZE		00	603	08	305	1206		
Sol	dering	Reflov	v/Wave	Reflow	//Wave	Reflow/Wave		
	WVDC	25V	50V	25V	50V	25V	50V	
271	Cap 270	G	G					
331	(pF) 330	G	G	J	J			
471	470	Ğ	G	j	j			
681	680	G	G	J	J			
102	1000	G	G	J	J	J	J	
152	1500	G	G	J	J	J	J	
182	1800	G	G	J	J	J	J	
222	2200	G	G	J	J	J	J	
272	2700	G	G	J	J	J	J	
332 392	3300 3900	G	G G	J	J	J		
472	3900 4700	G	G	J	J	J	J	
560	5600	G	G	J	J		1	
682	6800	G	G	J	J		1	
822	8200	G	Ğ	j	j	j	j	
103	Cap 0.01	Ğ	Ğ	J	J	-	Ĵ	
123	(μF) 0.012	G	G	j	J	j	J	
153	0.015	G	G	J	J	J	J	
223	0.022	G	G	J	J	J	J	
273	0.027	G	G	J	J	J	J	
333	0.033	G	G	J	J	J	J	
393	0.039	G	G	J	J	J	J	
473 563	0.047 0.056	G	G	N N	J N	M	M	
683	0.068	G		N N	N N	M	M	
823	0.082	- 6		N N	N N	M	M	
104	0.002			Ň	Ň	M	M	
124	0.12			N	N	M	M	
154	0.15			N	N	M	M	
184	0.18			N		M	M	
224	0.22			N		M	M	
274	0.27					M	M	
334	0.33					M	M	
394	0.39					M		
474 684	0.47 0.68					M	_	
105	0.08						-	
155	1.5							
225	2.2							
	WVDC Z.Z	25V	50V	25V	50V	25V	50V	

X8L (Flexiterm Offered)

	SIZE		060	3		0805		1206			1210			
So	ldering		Reflow/Wave			Reflow/Wave			Reflow	/Wave		Reflow/Wave		
	WVDC	25V	50V	100V	25V	50V	100V	16V	25V	50V	100V	10V	50V	100V
271	Cap 27		G											
331	(pF) 33		G	G	J	J	J							
471	47		G	G	J	J	J							
681	68		G	G	J	J	J							
102	100		G	G	J	J	J		J	J				
152	150		G	G	J	J	J		J	J	J			
182	180		G	G	J	J	J		J	J	J			
222	220		G	G	J	J	J		J	J	J			
272	270		G	G	J	J	J		J	J	J			
332	330		G	G	J	J	J		J	J	J			
392	390		G	G	J	J	J		J	J	J			
472	470		G	G	J	J	J		J	J	J			
562	560		G	G	J	J	J		J	J	J			
682	680) G	G	G	J	J	J		J	J	J			
822	820	No FI	ex G	G	J	J	J		J	J	J			
103	Cap 0.0	G	G	G	J	J	J		J	J	J			$\overline{}$
123	(µF) 0.01	G	G		J	J	J		J	J	J			-
153	0.01	G	G		J	J	J		J	J	J			-
183	0.01	G	G		J	J	J		J	J	J			-
223	0.02	G	G		J	J	J		J	J	J			-
273	0.02	G	G		J	J	J		J	J	J			_
333	0.03	G	G		J	J	N		J	J	J			-
393	0.03	G	G		J	J	N		J	J	J			-
473	0.04	G	G		J	J	N		J	J	J			-
563	0.05	G	G		J	J	N		J	J	J			-
683	0.06	G	G		J	J	N		J	J	J			-
823	0.08	2 G	G		J	J	N		J	J	J			_
104	0.	G	G		J	J	N		J	J	M			_
124	0.1	2			J	N			J	J	M			_
154	0.1				J	N		J	J	J	Q			-
184	0.1				N	N		J	J	J	Q			
224	0.2				N	N		J	J	J	Q			
274	0.2	,			N			J	M	M	Q			$\overline{}$
334	0.3				N			J	M	M	Q			$\overline{}$
394	0.3			1	N			M	M	P	Q			$\overline{}$
474	0.4	_			N			M	M	Р	Q			$\overline{}$
684	0.6	3			N			M	M	Р	Q			\vdash
824	0.8	2			N			M	M	Р	Q			-
105					N			M	M	Р	Q			-
155	1.	5						M	M					
225	2.	2			l			M	M				Z	Z
475		1			i –								Z	
106		1			i							Z		\vdash
	WVD	25V	50V	100V	25V	50V	100V	16V	25V	50V	100V	10V	50V	100V
	SIZE	1	060			0805			12				1210	
SIZE			0603			บชบอ			12				1210	

Letter	Α	С	Е	G	J	K	М	N	Р	Q	Х	Υ	Z	= AEC-Q200
Max.	0.33	0.56	0.71	0.90	0.94	1.02	1.27	1.40	1.52	1.78	2.29	2.54	2.79	Qualified
Thickness	(0.013)	(0.022)	(0.028)	(0.035)	(0.037)	(0.040)	(0.050)	(0.055)	(0.060)	(0.070)	(0.090)	(0.100)	(0.110)	
	PAPER							EMBOSSED						

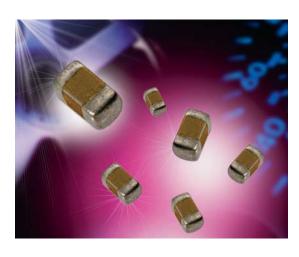
X8R/X8L Dielectric

General Specifications

APPLICATIONS FOR X8R AND X8L CAPACITORS

- All market sectors with a 150°C requirement
- · Automotive on engine applications
- · Oil exploration applications
- · Hybrid automotive applications
 - Battery control
 - Inverter / converter circuits
 - Motor control applications
 - Water pump
- · Hybrid commercial applications
 - Emergency circuits
 - Sensors
 - Temperature regulation



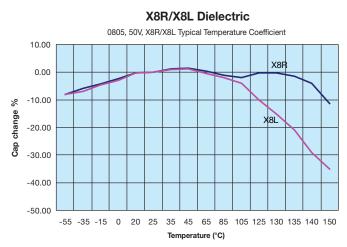


ADVANTAGES OF X8R AND X8L MLC CAPACITORS

- Both ranges are qualified to the highest automotive AEC-Q200 standards
- Excellent reliability compared to other capacitor technologies
- RoHS compliant
- · Low ESR / ESL compared to other technologies
- · Tin solder finish
- FLEXITERM® available
- Epoxy termination for hybrid available
- 100V range available

ENGINEERING TOOLS FOR HIGH VOLTAGE MLC CAPACITORS

- Samples
- Technical Articles
- Application Engineering
- Application Support



X8R/X8L Dielectric

Specifications and Test Methods

Capacitance Within specified tolerance Freq.: 1.0 kHz ± 10% Voltage: 1.0 Vrms ± .2V Dissipation Factor ≤ 2.5% for ≥50V DC rating Voltage: 1.0 Vrms ± .2V Insulation Resistance 100,000MΩ or 1000MΩ - μF, whichever is less Charge device with rated voltage for 120 ± 5 secs @ room temp/humidity Dielectric Strength No breakdown or visual defects Charge device with 250% of rated voltage for 120 ± 5 seconds, w/charge and discharge curren limited to 50 mA (max) Note: Charge device with 150% of rated voltage for 5.00V devices. Deflection: 2mm Capacitance Variation Factor Solderability Meets Initial Values (As Above) Solderability Appearance No defects (25% leaching of either end terminal capacitance Variation Dissipation Factor No defects (25% leaching of either end terminal capacitance Variation Pactor Dip device in eutectic solder at 230 ± 5°C for 60 seconds. Resistance to Solder Heat Meets Initial Values (As Above) Dip device in eutectic solder at 260°C for 60 seconds. Store at room temperature for 24 ± 2 hours before measuring electrical properties	Parameter/Test		X8R/X8L Specification Limits	Measuring Conditions				
Solderability Solder Heat Solder Heat Solder Heat Solder Appearance Solder Heat Solder Heat Solder Heat Solder Heat Solder Heat Solder Heat Solder Appearance Solder Heat Solder Heat Solder Heat Solder Resistance Solder Heat Solder Appearance Solder Heat Solder Solder Heat Solder Solder Heat Solder Solder Heat Solder Solder Heat Solder Solder Heat Solder Solder Heat Solder Solder Heat Solder Solder Heat Solder Solder Heat Solder Solder Solder Heat Solder Solde			-55°C to +150°C	Temperature Cycle Chamber				
Solder Heat Sologer Heat Solder Heat Solder Heat Solder Heat Solder Heat	Capac	itance						
Dielectric Strength No breakdown or visual defects Personance	Dissipati	on Factor		•				
Pielectric Strength No breakdown or visual defects Postpace device with 250% of rated voltage for 1-5 seconds, wicharge and discharge curren limited to 50 mA (max) Note: Charge device with 150% of rated voltage for 500V devices. Pelection: 2mm Test Time: 30 seconds Test Time: 4 1	Insulation Resistance							
Resistance to Flexure Stresses Resistance Stresses Appearance Capacitance Variation Dissipation Factor Insulation Resistance Solderability Appearance Appearance Solderability Appearance Appearance Solderability Appearance Capacitance Variation Resistance Appearance Capacitance Variation Dissipation Factor No defects Solder at 230 ± 5°C with fresh solder No defects, <25% leaching of either end terminal Capacitance Variation Dissipation Factor Insulation Factor Insulation Resistance Meets Initial Values (As Above) Meets Initial Values (As Above) Meets Initial Values (As Above)	Dielectric Strength		No breakdown or visual defects	Charge device with 250% of rated voltage for 1-5 seconds, w/charge and discharge current limited to 50 mA (max) Note: Charge device with 150% of rated				
Resistance to Flexure Stresses Dissipation Factor		Appearance	No defects					
Flexure Stresses Dissipation Factor	Resistance to	Capacitance	≤ ±12%	Test Time:	_			
Resistance Solderability Appearance Capacitance Variation Dissipation Factor Insulation Resistance Resistance Needs Initial Values (As Above) Ploy device in eutectic solder at 230 ± 5°C for 5.0 ± 0.5 seconds Dip device in eutectic solder at 230 ± 5°C for 5.0 ± 0.5 seconds Dip device in eutectic solder at 260°C for 60 seconds. Store at room temperature for 24 ± 2 hours before measuring electrical properties		Dissipation	Meets Initial Values (As Above)		Tillil/sec			
Solderability with fresh solder for 5.0 ± 0.5 seconds Appearance No defects, <25% leaching of either end terminal Capacitance ≤ ±7.5% Variation Dissipation Factor Meets Initial Values (As Above) Insulation Meets Initial Values (As Above) Resistance Meets Initial Values (As Above)			≥ Initial Value x 0.3	90 mm				
Appearance No defects, <25% leaching of either end terminal Capacitance	Solde			Dip device in eutectic solder at 230 ± 5%				
Resistance to Solder Heat Variation		Appearance						
Resistance to Solder Heat Dissipation Meets Initial Values (As Above) seconds. Store at room temperature for 24 ± 2 hours before measuring electrical properties			≤ ±7.5%	Dip device in cutestic	and an at 26000 for 60			
Resistance Meets Initial Values (As Above)	Resistance to		Meets Initial Values (As Above)	seconds. Store at room temperature for 24 ± 2				
Dielectric	Solder Heat		Meets Initial Values (As Above)	— Hours before measuri	ng electrical properties.			
Strength Meets Initial Values (As Above)		Dielectric Strength	Meets Initial Values (As Above)					
Appearance No visual defects Step 1: -55°C ± 2° 30 ± 3 minutes			No visual defects	Step 1: -55°C ± 2°	30 ± 3 minutes			
Capacitance ≤ ±7.5% Step 2: Room Temp ≤ 3 minutes			≤ ±7.5%	Step 2: Room Temp	≤ 3 minutes			
Thermal Shock Dissipation Factor Meets Initial Values (As Above) Step 3: +125°C ± 2° 30 ± 3 minutes			Meets Initial Values (As Above)	Step 3: +125°C ± 2°	30 ± 3 minutes			
Insulation Resistance Meets Initial Values (As Above) Step 4: Room Temp ≤ 3 minutes	SHOCK		Meets Initial Values (As Above)	· ·				
Strength Meets Initial Values (As Above) 24 ± 2 hours at room temperature				Repeat for 5 cycles and measure after 24 ± 2 hours at room temperature				
Appearance No visual defects			No visual defects	,				
Capacitance Series Ser		Variation	≤ ±12.5%	test chamber se	et at 150°C ± 2°C			
Dissipation ≤ Initial Value x 2.0 (See Above) for 1000 hours (+48, -0)	Load Life	_ '	≤ Initial Value x 2.0 (See Above)	for 1000 ho	ours (+48, -0)			
Insulation Resistance ≥ Initial Value x 0.3 (See Above) Remove from test chamber and stabilize at room temperature for 24 ± 2 hours		Resistance	≥ Initial Value x 0.3 (See Above)					
Dielectric Strength Meets Initial Values (As Above) before measuring.			Meets Initial Values (As Above)	before n	neasuring.			
Appearance No visual defects Store in a test chamber set at 85°C ± 2°C/			No visual defects	Store in a test cham	har sat at 85°C ± 2°C/			
Capacitance ≤ ±12.5% 85% ± 5% relative humidity for 1000 hours (±48, 0) with rated voltage applied.		Variation	≤ ±12.5%	85% ± 5% relative h	umidity for 1000 hours			
Load Dissipation ≤ Initial Value x 2.0 (See Above) (+48, -0) with rated voltage applied.		· ·	≤ Initial Value x 2.0 (See Above)					
Insulation Resistance ≥ Initial Value x 0.3 (See Above) Remove from chamber and stabilize at room temperature and humidity for			≥ Initial Value x 0.3 (See Above)	room temperatur	e and humidity for			
Dielectric Strength Meets Initial Values (As Above) 24 ± 2 hours before measuring.			Meets Initial Values (As Above)	24 ± 2 nours b	eiore measuring.			

